MOSFET - Power, Dual, N-Channel, SOIC-8 30 V, 8 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual SOIC-8 Surface Mount Package Saves Board Space

Applications

- Disk Drives
- DC-DC Converters
- Printers

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Ratir	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain			I _D	6.4	Α
Current R _{θJA} (Note 1)		T _A = 70°C		5.1	
Power Dissipation R ₀ JA (Note 1)		T _A = 25°C	P _D	1.28	W
Continuous Drain]	T _A = 25°C	I_{D}	4.9	Α
Current R _{θJA} (Note 2)	Steady	T _A = 70°C		3.9	
Power Dissipation R _{0JA} (Note 2)	State	T _A = 25°C	P _D	0.75	W
Continuous Drain]	T _A = 25°C	I _D	8.0	Α
Current R _{0JA} t < 10 s (Note 1)		T _A = 70°C		6.4	
Power Dissipation R _{θJA} t < 10 s (Note 1)		T _A = 25°C	P _D	2.0	W
Pulsed Drain Current	T _A = 25°C, t _p = 10 μs		I _{DM}	32	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)			I _S	2.0	Α
Single Pulse Drain-to-Source Avalanche Energy T_J = 25C, V_{DD} = 30 V, V_{GS} = 10 V, I_L = 11 A_{pk} , L = 1.0 mH, R_G = 25 Ω			EAS	60.5	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

THERMAL RESISTANCE RATINGS

Rating	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	97.5	
Junction-to-Ambient – t ≤ 10 s (Note 1)	$R_{\theta JA}$	62	°C/W
Junction-to-FOOT (Drain)	$R_{\theta JF}$	40	-0/00
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	167.5	

^{1.} Surface-mounted on FR4 board using 1 inch sq pad size, 1 oz $\,$ Cu.

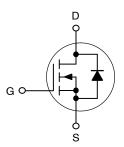


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	V _{(BR)DSS} R _{DS(on)} Max	
30 V	20 mΩ @ 10 V	8 A
	27 mΩ @ 4.5 V	071

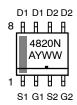
N-Channel



MARKING DIAGRAM & PIN ASSIGNMENT



SOIC-8 CASE 751 STYLE 11



4820N = Device Code
A = Assembly Location
Y = Year
WW = Work Week

= Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMD4820NR2G	SOIC-8 (Pb-Free)	2500/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

2.	Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)jk

Characteristic	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_{D}$	₀ = 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				26		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C T _J = 100°C			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _O	_{3S} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _E	ο = 250 μΑ	1.5		3.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J		·		5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 7.5 A		15	20	0
		V _{GS} = 4.5 V	I _D = 6.5 A		20	27	mΩ
Forward Transconductance	g _{FS}	V _{DS} = 1.5 V,	I _D = 7.5 A		21		S
CHARGES, CAPACITANCES AND GATE F	RESISTANCE						
Input Capacitance	C _{ISS}				940		pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 N	//Hz, V _{DS} = 15 V		225		
Reverse Transfer Capacitance	C _{RSS}	1			125		
Total Gate Charge	Q _{G(TOT)}				7.7		
Threshold Gate Charge	Q _{G(TH)}				1.1		7 , 1
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} =$	15 V, I _D = 7.5 A		3.3		nC
Gate-to-Drain Charge	Q_{GD}	1			3.2		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 7.5 A			15.2		nC
SWITCHING CHARACTERISTICS (Note 4)	•						
Turn-On Delay Time	t _{d(ON)}				9.4		
Rise Time	t _r	V _{GS} = 10 V, V	nn = 15 V.		4.0		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 1.0 \text{ A}, R_G = 6.0 \Omega$			21		ns
Fall Time	t _f	1			6.5		1
DRAIN-TO-SOURCE CHARACTERISTICS	;						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V	T _J = 25°C		0.75	1.0	V
		I _D = 2.0 A	T _J = 125°C		0.59		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = 2.0 \text{ A}$			17.8		1
Charge Time	T _a				8.3		ns -
Discharge Time	T _b				9.5		
Reverse Recovery Time	Q _{RR}				8.0		nC
PACKAGE PARASITIC VALUES	-				-	-	-
Source Inductance	L _S				0.66		nH
Drain Inductance	L _D	T _A = 25°C			0.20		nH
Gate Inductance	L _G				1.50		nH
Gate Resistance	R _G				1.5	3.0	Ω

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

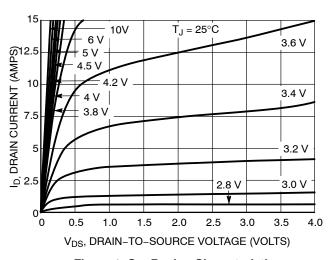
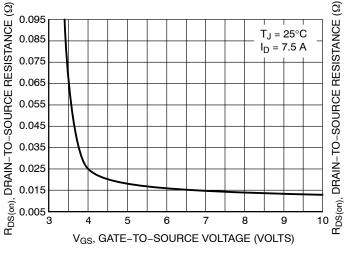


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



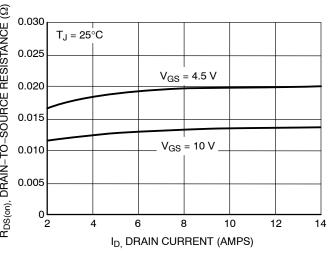
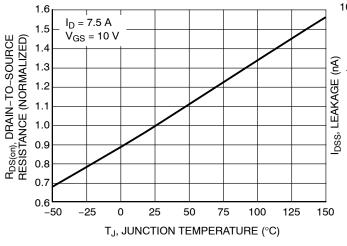


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



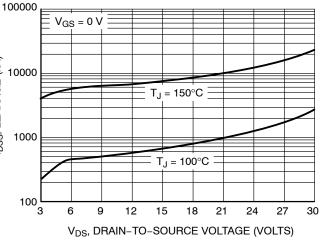


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES

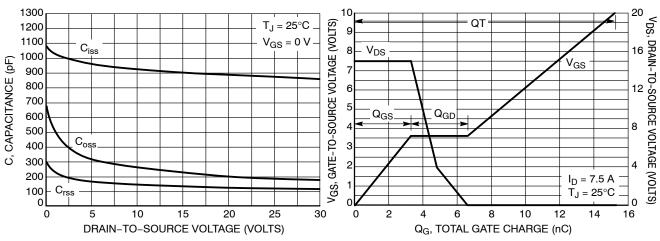


Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

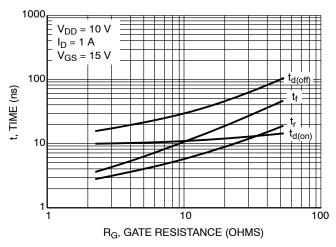


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

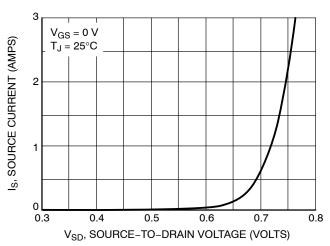


Figure 10. Diode Forward Voltage vs. Current

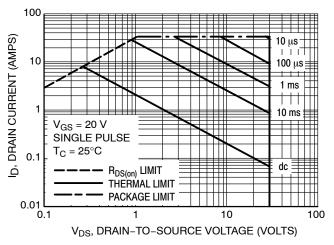


Figure 11. Maximum Rated Forward Biased Safe Operating Area

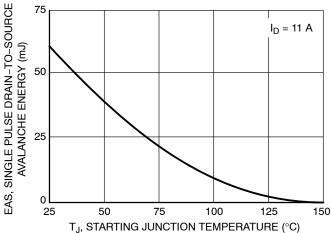
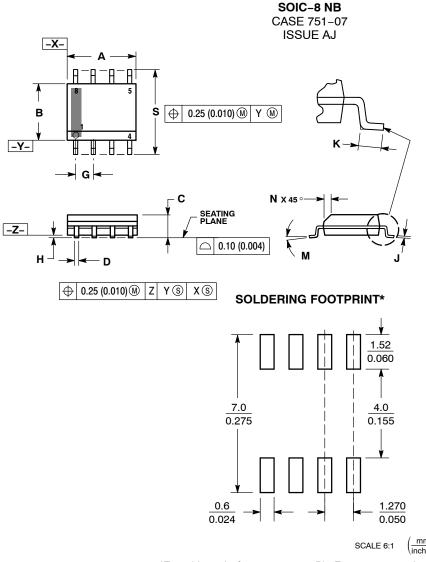


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

PACKAGE DIMENSIONS



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION A AND B DO NOT INCLUDE
- MOLD PROTRUSION.
 MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.

 DIMENSION D DOES NOT INCLUDE DAMBAR
- PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT
- MAXIMUM MATERIAL CONDITION. 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIN	IETERS	INC	HES		
DIM	MIN	MAX	MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
С	1.35	1.75	0.053	0.069		
D	0.33	0.51	0.013	0.020		
G	1.27	1.27 BSC		0.050 BSC		
Н	0.10	0.25	0.004	0.010		
J	0.19	0.25	0.007	0.010		
K	0.40	1.27	0.016	0.050		
M	0 °	8 °	0 °	8 °		
N	0.25	0.50	0.010	0.020		
S	5.80	6.20	0.228	0.244		

STYLE 11:

- SOURCE 1
- GATE 1 2
- SOURCE 2
- GATE 2 DRAIN 2
- 5. 6. DRAIN 2
- DRAIN 1 DRAIN 1

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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